Electronic, Thermal, and (Some) Unusual Applications of 2D Materials

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This talk will present recent highlights from our research on two-dimensional (2D) materials, including graphene, boron nitride (h-BN), and transition metal dichalcogenides (TMDs). Our results span from material growth and fundamental measurements, to simulations, devices, and system-oriented applications. We have grown monolayer 2D semiconductors over large areas, including MoS_2 [1], WSe_2 , and $MoSe_2$ [2]. We also uncovered that $ZrSe_2$ and $HfSe_2$ have native high- κ dielectrics ZrO_2 and HfO_2 , which are of key technological relevance [3]. Improved electrical contacts [4] led to the realization of monolayer MoS_2 transistors with high current density [5,6], near ballistic limits [7]. We have also demonstrated new memory devices based on layered Mo-, Sb-, and Ge- tellurides [8,9]. These could all play a role in 3D heterogeneous integration of nanoelectronics, which presents significant advantages for energy-efficient computation [10]. I will also describe a few less conventional applications, where we used 2D materials as highly efficient thermal insulators [11] and as thermal transistors [12]. These could enable control of heat in "thermal circuits" analogous with electrical circuits. Combined, these studies reveal fundamental limits and some unusual applications of 2D materials, which take advantage of their unique properties.

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